

Description

The SX2313MI uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = -12V$ $I_D = -8A$

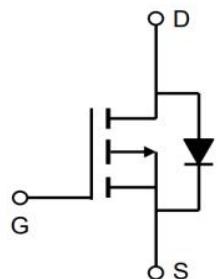
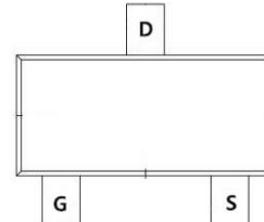
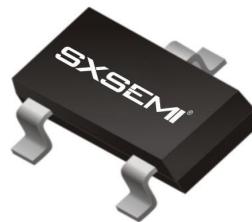
$R_{DS(ON)} < 20m\Omega$ @ $V_{GS}=4.5V$

Application

Lithium battery protection

Wireless impact

Mobile phone fast charging

**SOT-23-3L****Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise noted)**

| Symbol | Parameter | Rating | Units |
|------------------------|---|------------|-------|
| V_{DS} | Drain-Source Voltage | -12 | V |
| V_{GS} | Gate-Source Voltage | ± 12 | V |
| $I_D @ T_A=25^\circ C$ | Continuous Drain Current | 8.0 | A |
| $I_D @ T_A=70^\circ C$ | Continuous Drain Current | 5.3 | A |
| I_{DM} | Pulsed Drain Current ² | 40 | A |
| $P_D @ T_A=25^\circ C$ | Total Power Dissipation ³ | 1 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | °C |
| T_J | Operating Junction Temperature Range | -55 to 150 | °C |
| R_{eJA} | Thermal Resistance Junction-ambient ¹ | 125 | °C/W |
| R_{eJA} | Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$) | 85 | °C/W |

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Test Condition | Min. | Typ. | Max. | Units |
|------------------------------|--|--|------|-------|-----------|---------------------------|
| V(BR)DSS | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$ | -12 | -16 | - | V |
| $\Delta V_{BDSS}/\Delta T_J$ | BVDSS Temperature Coefficient | Reference to 25°C , $I_D=1\text{mA}$ | --- | 0.029 | --- | $\text{V}/^\circ\text{C}$ |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$ | -0.4 | -0.7 | -1.0 | V |
| RDS(on) | Static Drain-Source on-Resistance note2 | $V_{GS}=-4.5\text{V}$, $I_D=-8\text{A}$ | - | 16 | 20 | $\text{m}\Omega$ |
| | | $V_{GS}=-2.5\text{V}$, $I_D=-5\text{A}$ | - | 20 | 25 | |
| IDSS | Zero Gate Voltage Drain Current | $V_{DS}=-12\text{V}$, $V_{GS}=0\text{V}$, | - | - | -1 | μA |
| IGSS | Gate to Body Leakage Current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 12\text{V}$ | - | - | ± 100 | nA |
| C_{iss} | Input Capacitance | $V_{DS}=-6\text{V}$, $V_{GS}=0\text{V}$, $f=1.0\text{MHz}$ | - | 2700 | - | pF |
| Coss | Output Capacitance | | - | 680 | - | pF |
| Crss | Reverse Transfer Capacitance | | - | 590 | - | pF |
| Q_g | Total Gate Charge | $V_{DS}=-6\text{V}$, $I_D=-8\text{A}$, $V_{GS}=-4.5\text{V}$ | - | 35 | - | nC |
| Q_{gs} | Gate-Source Charge | | - | 5 | - | nC |
| Q_{gd} | Gate-Drain("Miller") Charge | | - | 10 | - | nC |
| td(on) | Turn-on Delay Time | $V_{DD}=-6\text{V}$, $I_D=-8\text{A}$, $V_{GS}=-4.5\text{V}$, $R_{GEN}=2.5\Omega$ | - | 11 | - | ns |
| t_r | Turn-on Rise Time | | - | 35 | - | ns |
| td(off) | Turn-off Delay Time | | - | 30 | - | ns |
| t_f | Turn-off Fall Time | | - | 10 | - | ns |
| IS | Maximum Continuous Drain to Source Diode Forward Current | - | - | -16 | A | |
| ISM | Maximum Pulsed Drain to Source Diode Forward Current | - | - | -64 | A | |
| VSD | Drain to Source Diode Forward Voltage | $V_{GS}=0\text{V}$, $I_S=-16\text{A}$ | - | -0.8 | -1.2 | V |

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
 2. Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

Typical Characteristics

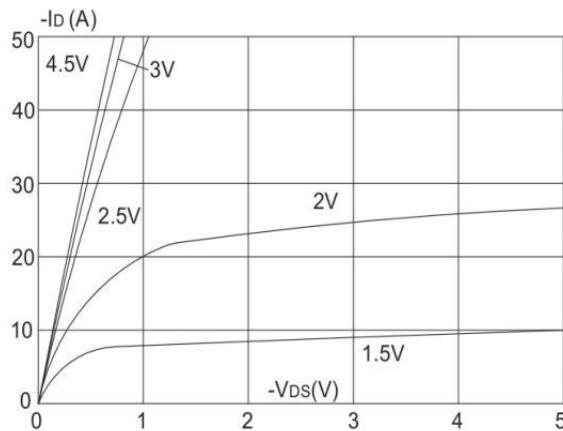


Figure 1: Output Characteristics

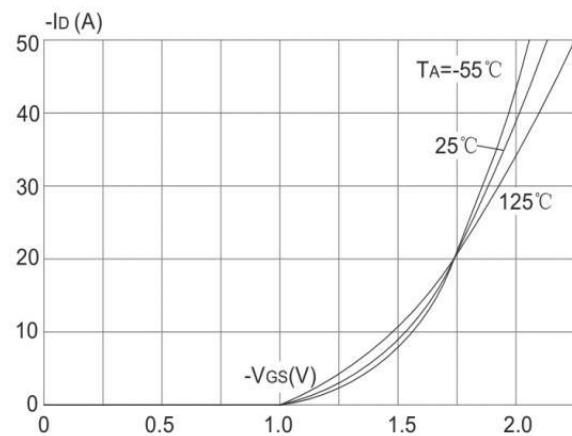


Figure 2: Typical Transfer Characteristics

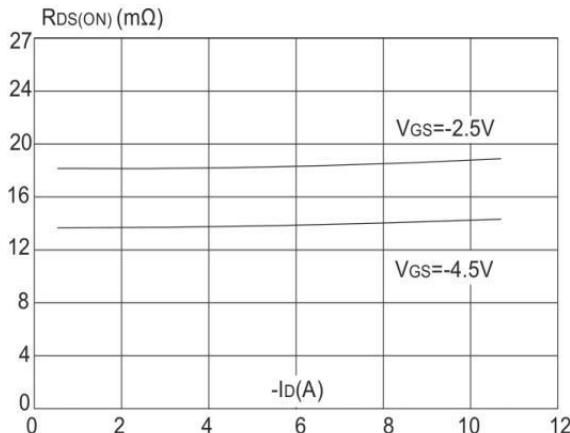


Figure 3: On-resistance vs. Drain Current

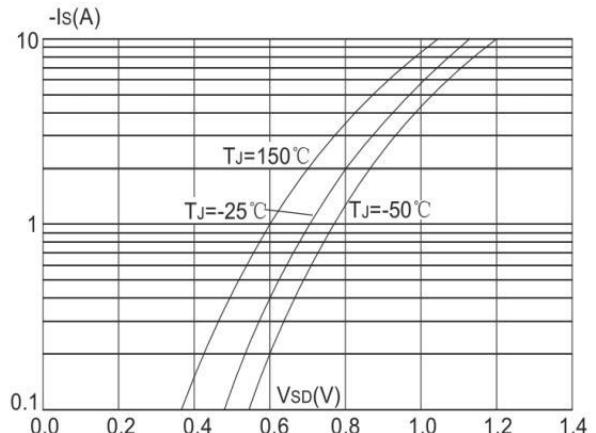


Figure 4: Body Diode Characteristics

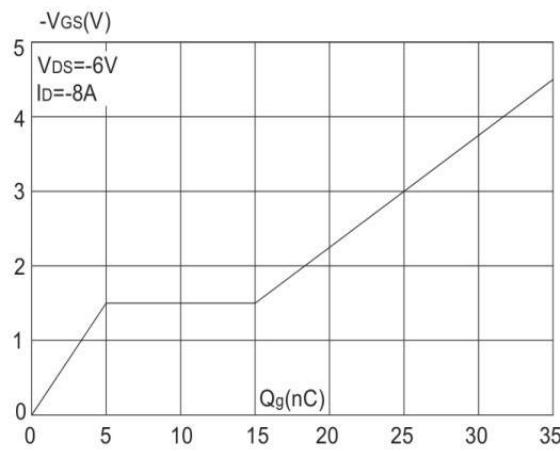


Figure 5: Gate Charge Characteristics

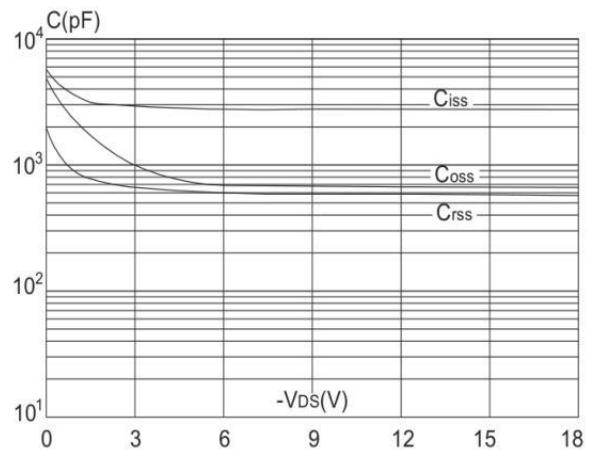


Figure 6: Capacitance Characteristics

Typical Characteristics

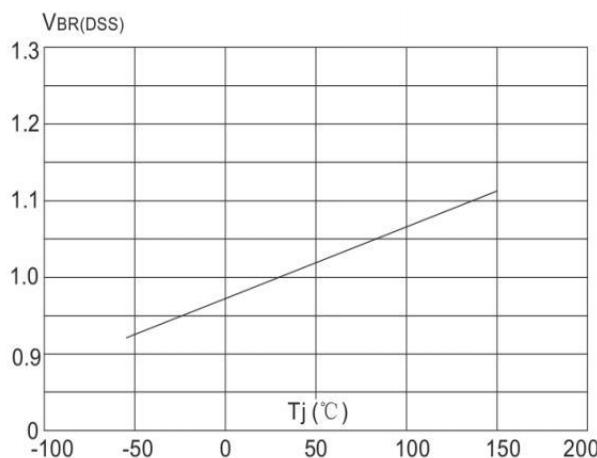


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

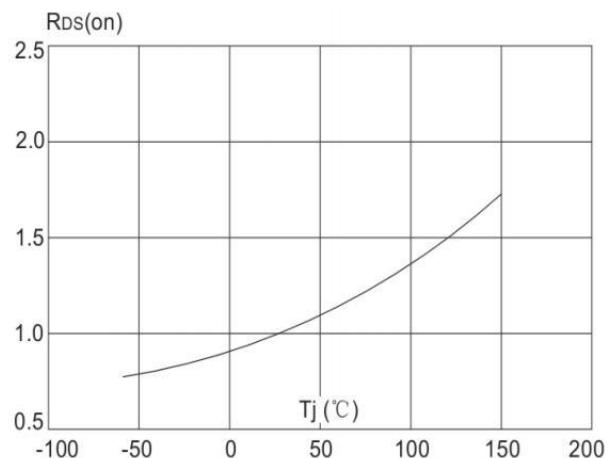


Figure 8: Normalized on Resistance vs. Junction Temperature

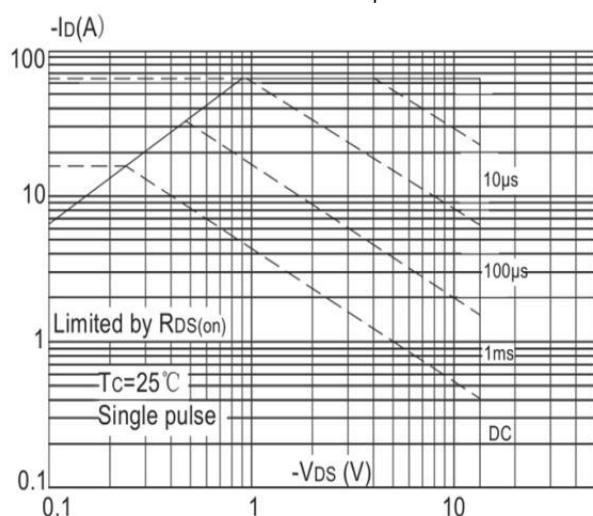


Figure 9: Maximum Safe Operating Area Case Temperature

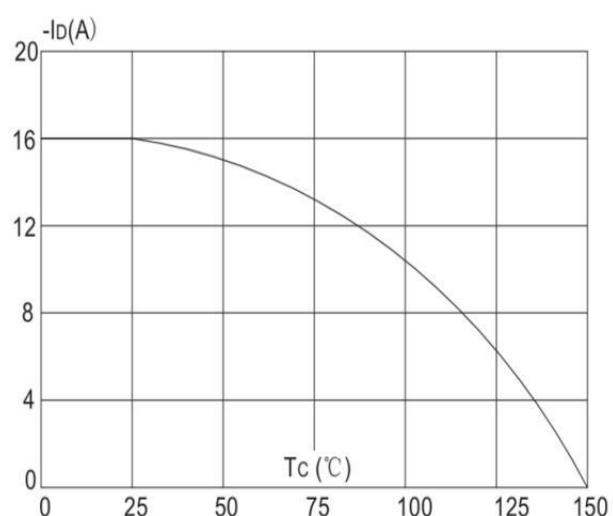


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

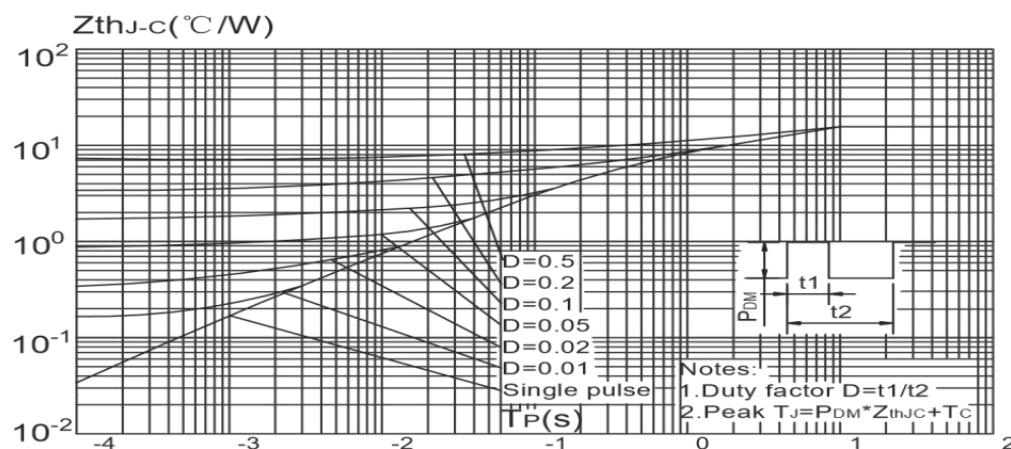
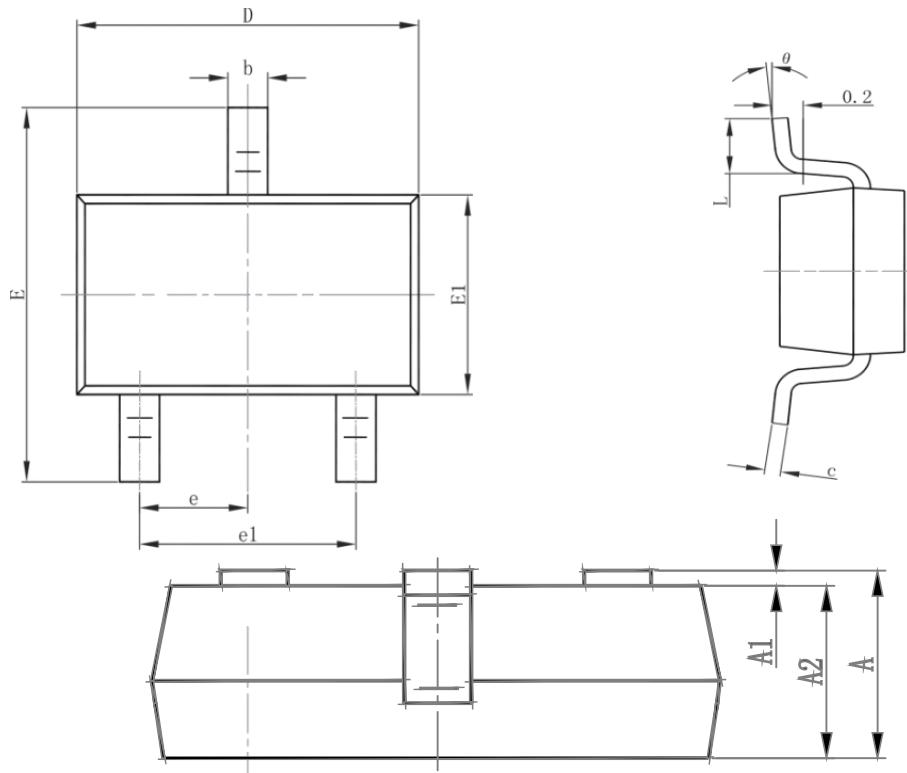


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

MOSFET Package Mechanical Data-SOT23-3



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 1.050 | 1.250 | 0.041 | 0.049 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 1.050 | 1.150 | 0.041 | 0.045 |
| b | 0.300 | 0.500 | 0.012 | 0.020 |
| c | 0.100 | 0.200 | 0.004 | 0.008 |
| D | 2.820 | 3.020 | 0.111 | 0.119 |
| E1 | 1.500 | 1.700 | 0.059 | 0.067 |
| E | 2.650 | 2.950 | 0.104 | 0.116 |
| e | 0.950(BSC) | | 0.037(BSC) | |
| e1 | 1.800 | 2.000 | 0.071 | 0.079 |
| L | 0.300 | 0.600 | 0.012 | 0.024 |
| θ | 0° | 8° | 0° | 8° |

Package Marking and Ordering Information

| Product ID | Pack | Marking | Qty(PCS) |
|------------|-----------|---------|----------|
| TAPING | SOT-23-3L | | 3000 |